

Search Notes

Application/Control No.

10/751,412

Examiner

Steven D. Maki

Applicant(s)/Patent under
Reexamination

MURATA, TAKEHIKO

Art Unit

1733

SEARCHED

| Class | Subclass | Date | Examiner |
|---------|----------|-----------|------------|
| 152 | 209.15 | | |
| | 209.16 | | |
| | 209.18 | | |
| | 209.22 | | |
| | 209.28 | | |
| D12 | 556 | | |
| | 559 | | |
| updated | above | 5/25/2006 | <i>SDM</i> |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |
| | | | |
| | | | |
| | | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|------|-----------|------------|
| none | 5/25/2006 | <i>SDM</i> |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |